

Surface Mount Clock Oscillator

- Immediate Delivery
- Ultra Low Jitter
- Low Phase Noise



Part Numbering Example: FT305055ANM - XXX.XXXX M

F	T		3	050	55	AN	M	XXX.XXXX
SERIES	OUTPUT	PACKAGE STYLE	VOLTAGE	STABILITY	OPERATING TEMP.	STABILITY	TRI-STATE	FREQUENCY
Blank=Cmos	DV = Full Size	1= 1.8V	050= ±50 ppm	48= -40 °C + 85 °C	Blank=40/60%	I = Industrial Std	0.5 ~170MHz	
T = TTL	Xo53 = 3.2X5	3= 3.3 V	025= ±25 ppm	50= -55 °C +105°C	AN=45/55%	M= MIL-STD-883B		
	Blank = 5X7	5= 5.0V	020= ±20 ppm	55= -55 °C +125°C		B= MIL-PFR-55310D		

Specifications:

Description	Min	Typ	Max	Unit
Frequency Range: Programmable to Any Discrete Frequency	0.5		170.000	MHz
Available Stability Options:	-50 -25		50 25	ppm ppm
Supply Voltage Options: (1.5–133 MHz)	1.62	1.8	3.3 2.5 1.98	V
Operating Temperature Range Options:				
Storage Temperature:	-55		+125	°C
Aging (PPM/Year) Ta=25C, Vdd=3.3V/2.5V			±5	
Output Level: HCMOS/TTL				

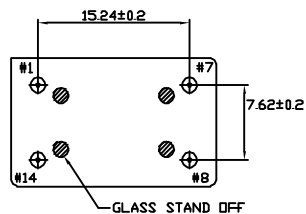
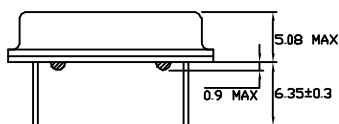
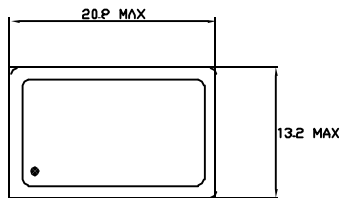
Operating Conditions:

Description	Min	Max	Unit
Vdd Rise Time:	100		µS
HCMOS Max Capacitive Load on outputs for CMOS levels Frequency: < 40 MHz Frequency: 40–133 MHz		25 15	pF pF

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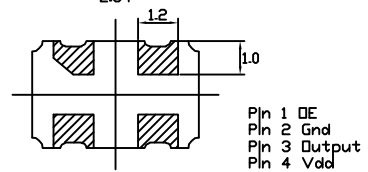
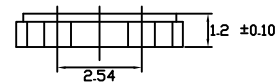
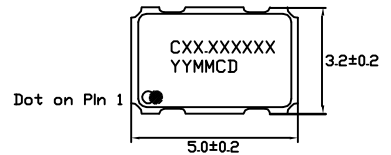
Full Size 14 Pin Dip

STYLE 1 FULL SIZE 14 PIN DIP

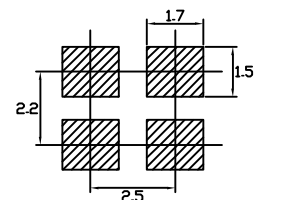


PIN FUNCTION
 1 CONTROL
 7 GND
 8 OUTPUT
 14 Vdd

3.2x5 Ceramic SMD

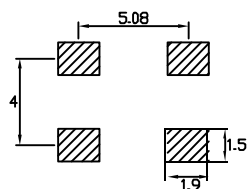
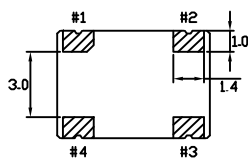
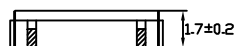
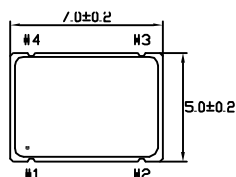


Pin 1 OE
 Pin 2 Gnd
 Pin 3 Output
 Pin 4 Vdd



Recommended solder pad layout

5x7 Ceramic SMD



PIN FUNCTION
 1 CONTROL
 2 GND
 3 OUTPUT
 4 Vdd

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Electrical Characteristics

Description	TEST CONDITIONS	Min	Typ	Max	Unit
Input Characteristics (Pin 1): V _{IL} , Low-Level Input Voltage TO DISABLE OUTPUT				0.2V _{dd}	V
V _{IH} , High-Level Input Voltage TO ENABLE OUTPUT OR open		0.7V _{dd}			
I _{IL} , Input Low Current I _{IH} , Input High Current	V _{IN} = 0V V _{IN} = V _{dd}			80 10	μA μA
Output Characteristics: V _{OL} , Low-Level Output Voltage	8 mA I _{OL}			0.4	V
V _{OHC} MOS, High-level HCMOS Voltage	-8 mA I _{OL}	V _{dd} -0.4			V V
Power Supply Current: (Loaded)	1.8V V _{dd} , OUTPUT FREQ < 133 MHz			15	mA
Tri-State Internal Pull-up:	1.8V V _{dd}	50	70	90	kΩ
Tri-State Leakage Current:	TS option, Pin 1 low			20	μA
Power Down Current:				10	μA

"Tristate internal pull up. Output active when high"

Output Clock Switching Characteristics

Description	TEST CONDITIONS	Min	Typ	Max	Unit
Duty Cycle: HCMOS @ V _{dd} /2		45		55	%
Output Clock Rise/Fall:	0.2–0.8V _{dd} , C _L = 15		2		nS nS
Start Up Time:			3	10	mS
RMS Period Jitter:			3	5	pS
RMS Integrated Jitter:	12kHz to 20MHz		10		pS
Phase Noise:	@ 10kHz			-120	dBc/Hz

Environmental And Mechanical	
Mechanical Shock	Per MIL-STD-883 ,Method 2002 ,Cond.B
Thermal Shock	Per MIL-STD-883 ,Method 1011 ,Cond.A
Vibration	Per MIL-STD-883 ,Method 2007 ,Cond.A
Seal	Per MIL-STD-883, Method 1014, Condition B & C
Solderability	Per MIL-STD-883 ,Method 2003 ,Cond.A